

Notice of References Cited

Application/Control No.

09/619,771

Applicant(s)/Patent Under

Reexamination

SIKKINK ET AL.

Examiner

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Art Unit

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Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,434,674	08-2002	DeWilde et al.	711/149
	B	US-			
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	F	US-			
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	I	US-			
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